

<b>Notice of References Cited</b>	Application/Control No. 10/826,059	Applicant(s)/Patent Under Reexamination TAKABAYASHI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0288386	12-2005	Ishikawa, Wataru	522/168
*	B	US-2005/0215657	09-2005	Nishizeki et al.	522/031
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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